

# H7N0602AB

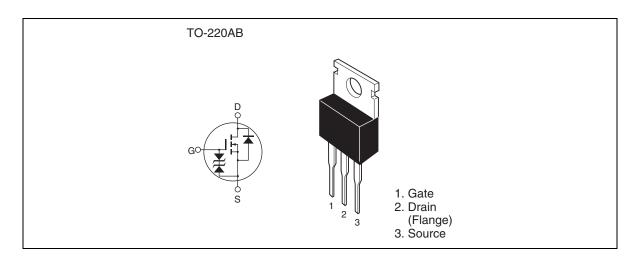
Silicon N Channel MOS FET High Speed Power Switching

REJ03G0068-0100Z Preliminary Rev.1.00 Aug.06.2003

### **Features**

- Low on-resistance  $R_{DS(on)} = 4.1 \text{ m}\Omega \text{ typ.}$
- Low drive current
- Capable of 4.5 V gate drive

### **Outline**



# **Absolute Maximum Ratings**

 $(Ta = 25^{\circ}C)$ 

| Item                                   | Symbol                                  | Ratings     | Unit |
|--|---|-------------|------|
| Drain to source voltage                | V <sub>DSS</sub>                        | 60          | V    |
| Gate to source voltage                 | V <sub>GSS</sub>                        | ±20         | V    |
| Drain current                          | I <sub>D</sub>                          | 85          | A    |
| Drain peak current                     | I <sub>D</sub> (pulse) <sup>Note1</sup> | 340         | A    |
| Body-drain diode reverse drain current | I <sub>DR</sub>                         | 85          | A    |
| Avalanche current                      | I <sub>AP</sub> Note3                   | 65          | A    |
| Avalanche energy                       | E <sub>AR</sub> Note3                   | 362         | mJ   |
| Channel dissipation                    | Pch <sup>Note2</sup>                    | 100         | W    |
| Channel temperature                    | Tch                                     | 150         | °C   |
| Storage temperature                    | Tstg                                    | -55 to +150 | °C   |

Notes: 1. PW  $\leq$  10  $\mu$ s, duty cycle  $\leq$  1%

2. Tc = 25°C

3. Value at Tch = 25°C, Rg  $\geq$  50  $\Omega$ 

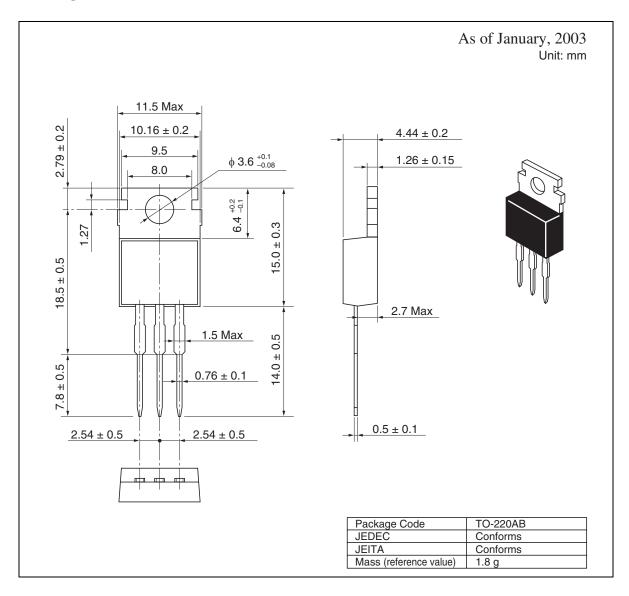
## **Electrical Characteristics**

 $(Ta = 25^{\circ}C)$ 

| Item                                   | Symbol              | Min | Тур  | Max | Unit      | <b>Test Conditions</b>                                      |
|--|---------------------|-----|------|-----|-----------|---|
| Drain to source breakdown voltage      | $V_{(BR)DSS}$       | 60  | _    | _   | V         | $I_D = 10 \text{ mA}, V_{GS} = 0$                           |
| Gate to source breakdown voltage       | $V_{(BR)GSS}$       | ±20 | _    | _   | V         | $I_G = \pm 100 \ \mu A, \ V_{DS} = 0$                       |
| Gate to source leak current            | I <sub>GSS</sub>    | _   | _    | ±10 | μΑ        | $V_{GS} = \pm 16 \text{ V}, V_{DS} = 0$                     |
| Zero gate voltage drain current        | I <sub>DSS</sub>    | _   | _    | 10  | μΑ        | $V_{DS} = 60 \text{ V}, V_{GS} = 0$                         |
| Gate to source cutoff voltage          | $V_{GS(off)}$       | 1.5 | _    | 2.5 | V         | $I_D = 1 \text{ mA}, V_{DS} = 10 \text{ V}^{\text{Note1}}$  |
| Static drain to source on state        | R <sub>DS(on)</sub> | _   | 4.1  | 5.2 | $m\Omega$ | $I_D = 45 \text{ A}, V_{GS} = 10 \text{ V}^{Note1}$         |
| resistance                             |                     | _   | 6.2  | 9.0 | $m\Omega$ | $I_D = 45 \text{ A}, V_{GS} = 4.5 \text{ V}^{Note1}$        |
| Forward transfer admittance            | y <sub>fs</sub>     | 70  | 120  | _   | S         | $I_D = 45 \text{ A}, V_{GS} = 10 \text{ V}^{\text{Note1}}$  |
| Input capacitance                      | Ciss                | _   | 9000 | _   | pF        | V <sub>DS</sub> = 10 V                                      |
| Output capacitance                     | Coss                | _   | 1000 | _   | pF        | $V_{GS} = 0$  |
| Reverse transfer capacitance           | Crss                | _   | 470  | _   | pF        | f = 1 MHz   |
| Total gate charge                      | Qg                  | _   | 140  | _   | nC        | V <sub>DD</sub> = 25 V                                      |
| Gate to source charge                  | Qgs                 | _   | 30   | _   | nC        | $V_{GS} = 10 \text{ V}$                                     |
| Gate to drain charge                   | Qgd                 | _   | 30   | _   | nC        | I <sub>D</sub> = 85 A                                       |
| Turn-on delay time                     | t <sub>d(on)</sub>  | _   | 55   | _   | ns        | $V_{GS} = 10 \text{ V}, I_D = 45 \text{ A}$                 |
| Rise time                              | t <sub>r</sub>      | _   | 290  | _   | ns        | $R_L = 0.67 \Omega$   |
| Turn-off delay time                    | t <sub>d(off)</sub> | _   | 140  | _   | ns        | $Rg = 4.7 \Omega$   |
| Fall time                              | t <sub>f</sub>      | _   | 50   | _   | ns        | _   |
| Body-drain diode forward voltage       | V <sub>DF</sub>     | _   | 0.95 | _   | V         | $I_F = 85 \text{ A}, V_{GS} = 0$                            |
| Body-drain diode reverse recovery time | t <sub>rr</sub>     | _   | 45   | _   | ns        | $I_F = 85 \text{ A}, V_{GS} = 0$<br>diF/dt = 100 A/ $\mu$ s |

Notes: 1. Pulse test

## **Package Dimensions**



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